

Notice of References Cited			Application/Control No.	Applicant(s)/Patent Under Reexamination KOBAYASHI ET AL.	
			Examiner Gelek Topgyal	Art Unit 2621	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,493,506	12-2002	Schoner et al.	386/126
*	B	US-5,798,995	08-1998	Fukushima et al.	386/98
*	C	US-5,642,338	06-1997	Fukushima et al.	386/96
*	D	US-5,596,564	01-1997	Fukushima et al.	386/70
*	E	US-7,167,640	01-2007	Gadre et al.	386/125
*	E	US-7,099,569	08-2006	Gadre et al.	386/125
*	G	US-6,570,837	05-2003	Kikuchi et al.	369/275.1
*	H	US-6,532,334	03-2003	Kikuchi et al.	386/68
*	I	US-2003/0049019	03-2003	Kimura, Masaru	386/96
*	J	US-6,771,877	08-2004	Ono et al.	386/46
*	K	US-5,365,502	11-1994	Misono, Kousuke	369/18
*	L	US-6,889,001	05-2005	Nikaido et al.	386/125
*	M	US-6,429,879	08-2002	Sturgeon et al.	715/723

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.